

NTD32N06

Power MOSFET

32 Amps, 60 Volts, N-Channel DPAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

Features

- Pb-Free Packages are Available
- Smaller Package than MTB36N06V
- Lower $R_{DS(on)}$
- Lower $V_{DS(on)}$
- Lower Total Gate Charge
- Lower and Tighter V_{SD}
- Lower Diode Reverse Recovery Time
- Lower Reverse Recovery Stored Charge

Typical Applications

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DS}	60	Vdc
Drain-to-Gate Voltage ($R_{GS} = 10\text{ M}\Omega$)	V_{DGR}	60	Vdc
Gate-to-Source Voltage, Continuous	V_{GS}	± 20	Vdc
– Non-Repetitive ($t_p \leq 10\text{ ms}$)	V_{GS}	± 30	Vdc
Drain Current			
– Continuous @ $T_A = 25^\circ\text{C}$	I_D	32	Adc
– Continuous @ $T_A = 100^\circ\text{C}$	I_D	22	
– Single Pulse ($t_p \leq 10\text{ }\mu\text{s}$)	I_{DM}	90	Apk
Total Power Dissipation @ $T_A = 25^\circ\text{C}$	P_D	93.75	W
Derate above 25°C		0.625	W/ $^\circ\text{C}$
Total Power Dissipation @ $T_A = 25^\circ\text{C}$ (Note 1)		2.88	W
Total Power Dissipation @ $T_A = 25^\circ\text{C}$ (Note 2)		1.5	W
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to $+175$	$^\circ\text{C}$
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^\circ\text{C}$ (Note 3) ($V_{DD} = 50\text{ Vdc}$, $V_{GS} = 10\text{ Vdc}$, $L = 1.0\text{ mH}$, $I_{L(pk)} = 25\text{ A}$, $V_{DS} = 60\text{ Vdc}$, $R_G = 25\text{ }\Omega$)	E_{AS}	313	mJ
Thermal Resistance – Junction-to-Case	$R_{\theta JC}$	1.6	$^\circ\text{C/W}$
– Junction-to-Ambient (Note 1)	$R_{\theta JA}$	52	
– Junction-to-Ambient (Note 2)	$R_{\theta JA}$	100	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T_L	260	$^\circ\text{C}$

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. When surface mounted to an FR4 board using 1" pad size, (Cu Area 1.127 in²).
2. When surface mounted to an FR4 board using minimum recommended pad size, (Cu Area 0.412 in²).
3. Repetitive rating; pulse width limited by maximum junction temperature.

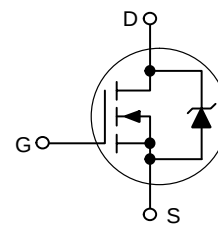


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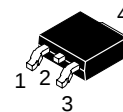
<http://onsemi.com>

$V_{(BR)DSS}$	$R_{DS(on)}$ TYP	I_D MAX
60 V	26 m Ω	32 A

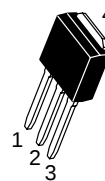
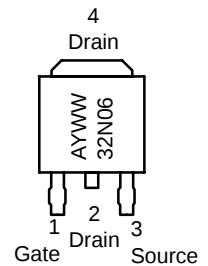
N-Channel



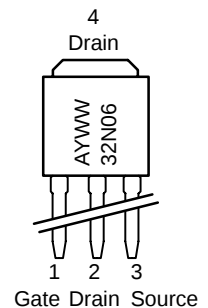
MARKING DIAGRAMS



DPAK
CASE 369C
STYLE 2



DPAK-3
CASE 369D
STYLE 2



32N06 = Device Code
A = Assembly Location
Y = Year
WW = Work Week

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

NTD32N06

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage (Note 4) (V _{GS} = 0 Vdc, I _D = 250 μAdc) Temperature Coefficient (Positive)	V _{(BR)DSS}	60 –	70 41.6	– –	Vdc mV/°C
Zero Gate Voltage Drain Current (V _{DS} = 60 Vdc, V _{GS} = 0 Vdc) (V _{DS} = 60 Vdc, V _{GS} = 0 Vdc, T _J = 150°C)	I _{DSS}	– –	– –	1.0 10	μAdc
Gate-Body Leakage Current (V _{GS} = ±20 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	–	–	±100	nAdc

ON CHARACTERISTICS (Note 4)

Gate Threshold Voltage (Note 4) (V _{DS} = V _{GS} , I _D = 250 μAdc) Threshold Temperature Coefficient (Negative)	V _{GS(th)}	2.0 –	2.8 7.0	4.0 –	Vdc mV/°C
Static Drain-to-Source On-Resistance (Note 4) (V _{GS} = 10 Vdc, I _D = 16 Adc)	R _{DS(on)}	–	21	26	mΩ
Static Drain-to-Source On-Voltage (Note 4) (V _{GS} = 10 Vdc, I _D = 20 Adc) (V _{GS} = 10 Vdc, I _D = 32 Adc) (V _{GS} = 10 Vdc, I _D = 16 Adc, T _J = 150°C)	V _{DS(on)}	– – –	0.417 0.680 0.633	0.62 – –	Vdc
Forward Transconductance (Note 4) (V _{DS} = 6 Vdc, I _D = 16 Adc)	g _{FS}	–	21.1	–	mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{iss}	–	1231	1725	pF
Output Capacitance		C _{oss}	–	346	485	
Transfer Capacitance		C _{rss}	–	77	160	

SWITCHING CHARACTERISTICS (Note 5)

Turn-On Delay Time	(V _{DD} = 30 Vdc, I _D = 32 Adc, V _{GS} = 10 Vdc, R _G = 9.1 Ω) (Note 4)	t _{d(on)}	–	10	25	ns
Rise Time		t _r	–	84	180	
Turn-Off Delay Time		t _{d(off)}	–	31	70	
Fall Time		t _f	–	93	200	
Gate Charge	(V _{DS} = 48 Vdc, I _D = 32 Adc, V _{GS} = 10 Vdc) (Note 4)	Q _T	–	33	60	nC
		Q ₁	–	6.0	–	
		Q ₂	–	15	–	

SOURCE-DRAIN DIODE CHARACTERISTICS

Forward On-Voltage	(I _S = 20 Adc, V _{GS} = 0 Vdc) (Note 4) (I _S = 32 Adc, V _{GS} = 0 Vdc) (Note 4) (I _S = 20 Adc, V _{GS} = 0 Vdc, T _J = 150°C)	V _{SD}	– – –	0.89 0.96 0.75	1.0 – –	Vdc
Reverse Recovery Time	(I _S = 32 Adc, V _{GS} = 0 Vdc, di _S /dt = 100 A/μs) (Note 4)	t _{rr}	–	52	–	ns
		t _a	–	37	–	
		t _b	–	14.3	–	
Reverse Recovery Stored Charge		Q _{RR}	–	0.095	–	μC

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
- Switching characteristics are independent of operating junction temperatures.

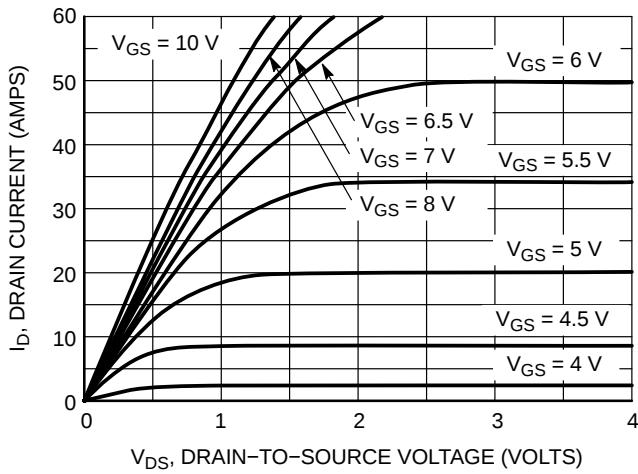


Figure 1. On-Region Characteristics

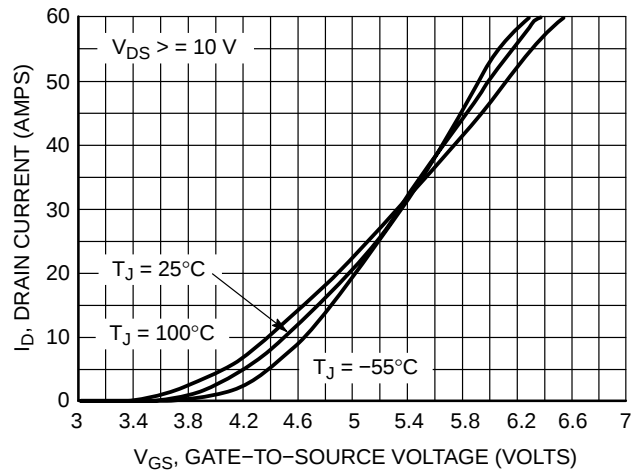


Figure 2. Transfer Characteristics

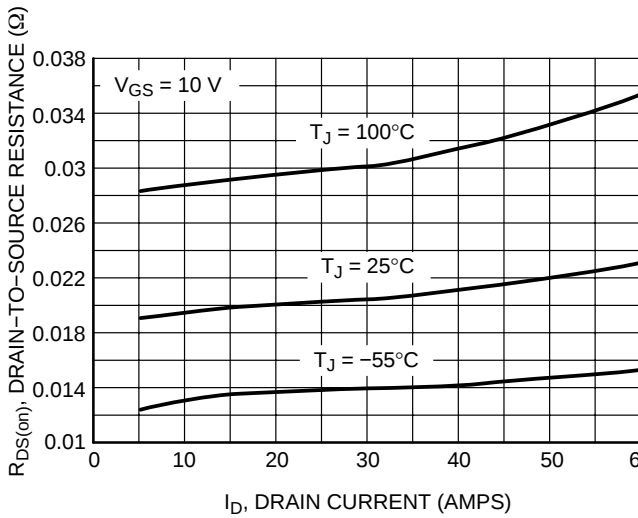


Figure 3. On-Resistance vs. Gate-to-Source Voltage

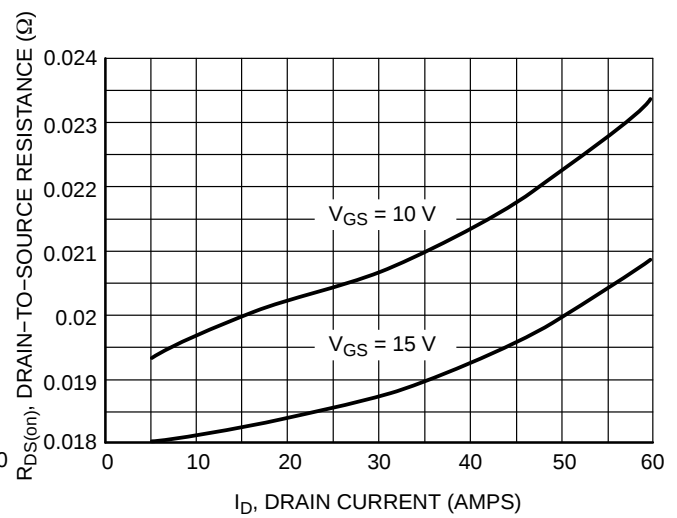


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

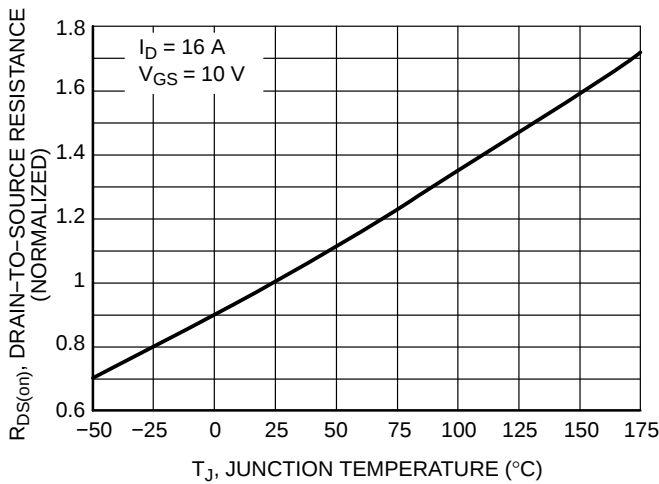


Figure 5. On-Resistance Variation with Temperature

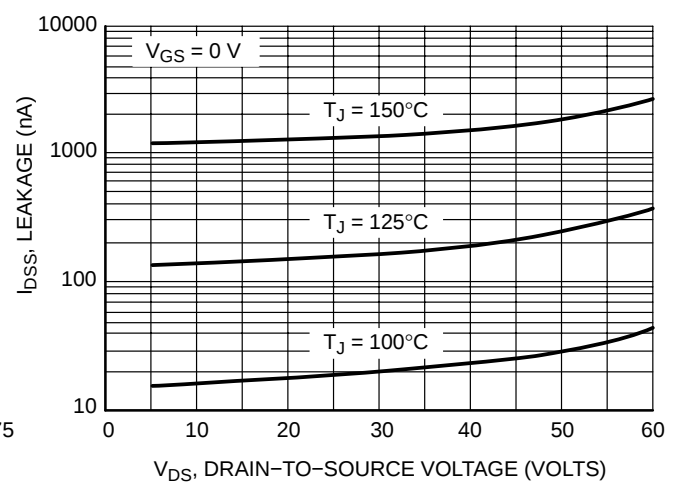


Figure 6. Drain-to-Source Leakage Current vs. Voltage

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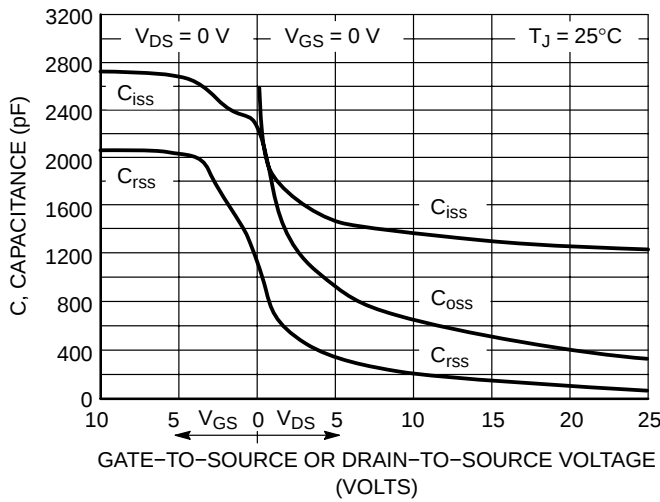


Figure 7. Capacitance Variation

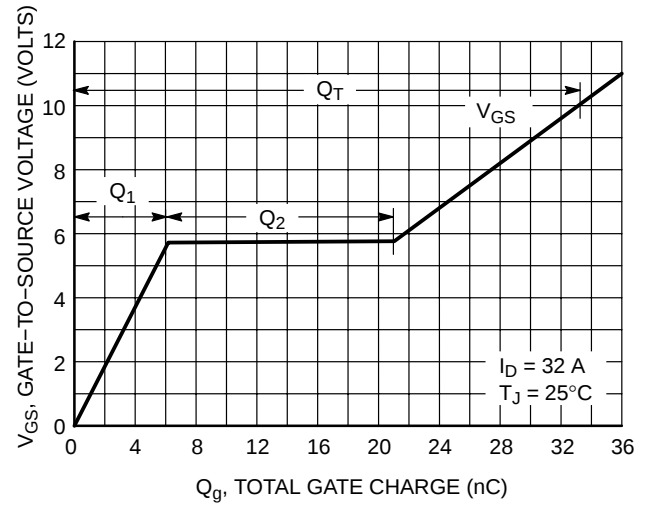


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

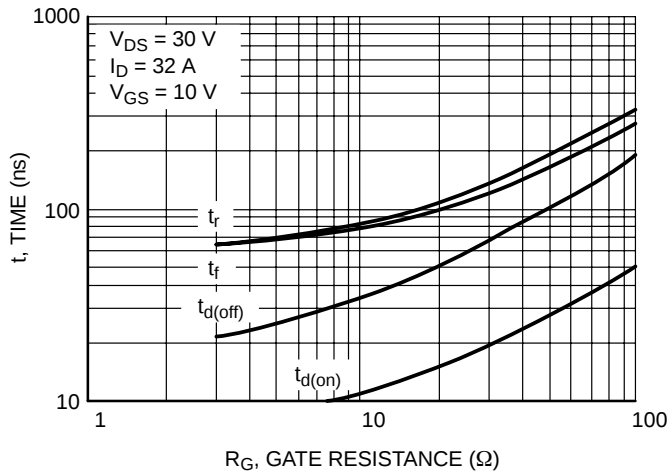


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

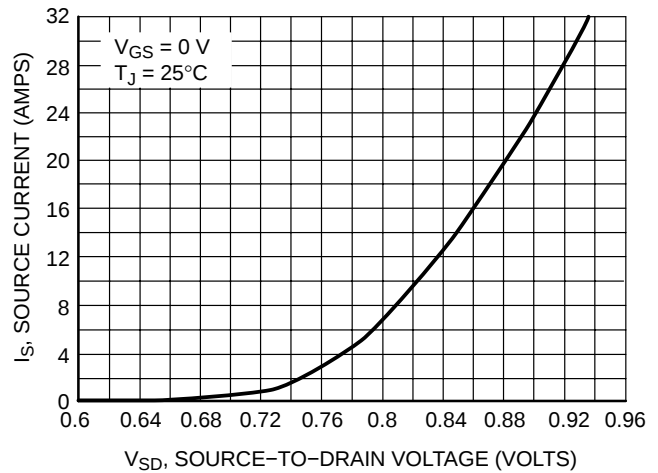


Figure 10. Diode Forward Voltage vs. Current

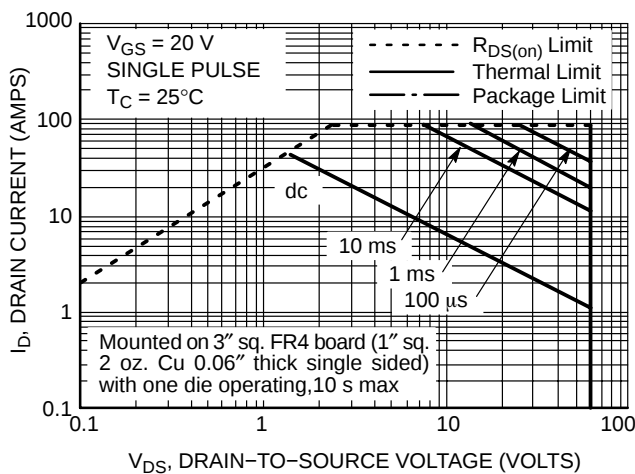


Figure 11. Maximum Rated Forward Biased Safe Operating Area

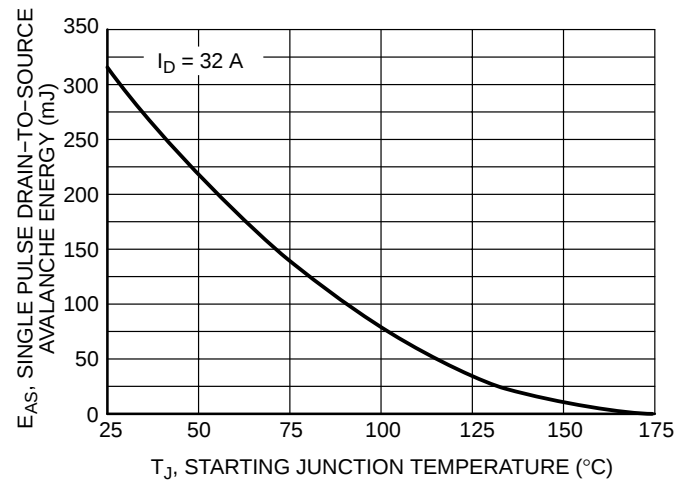


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

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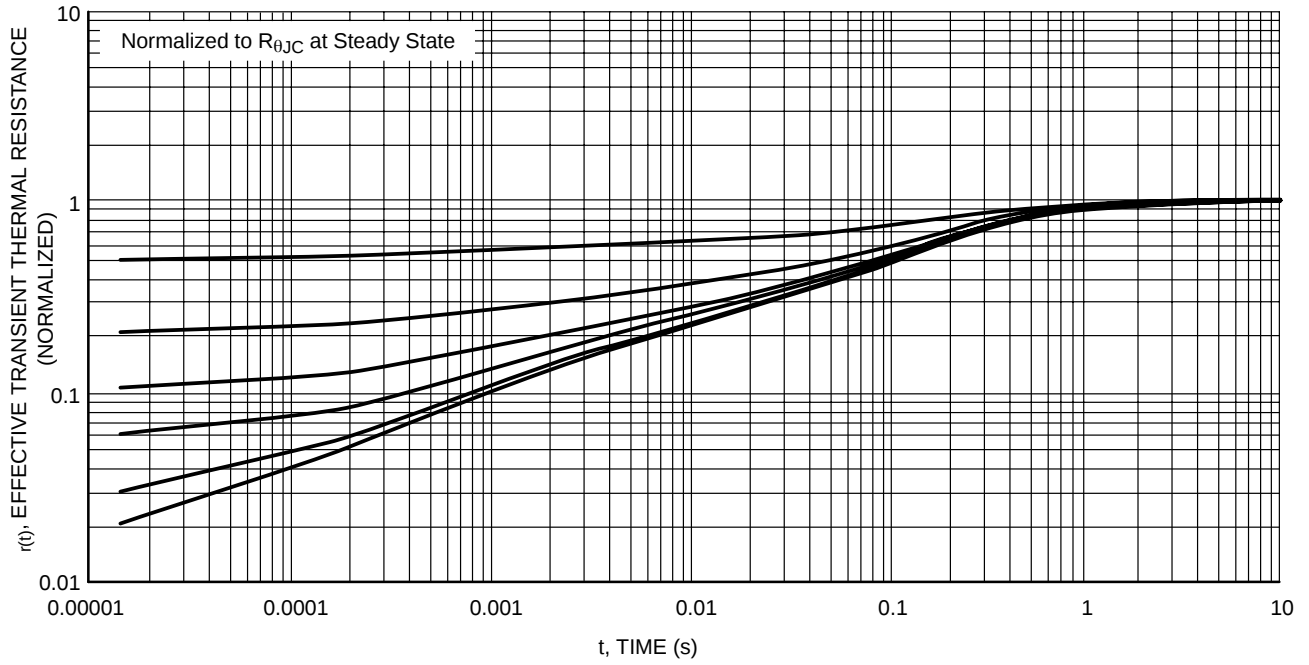


Figure 13. Thermal Response

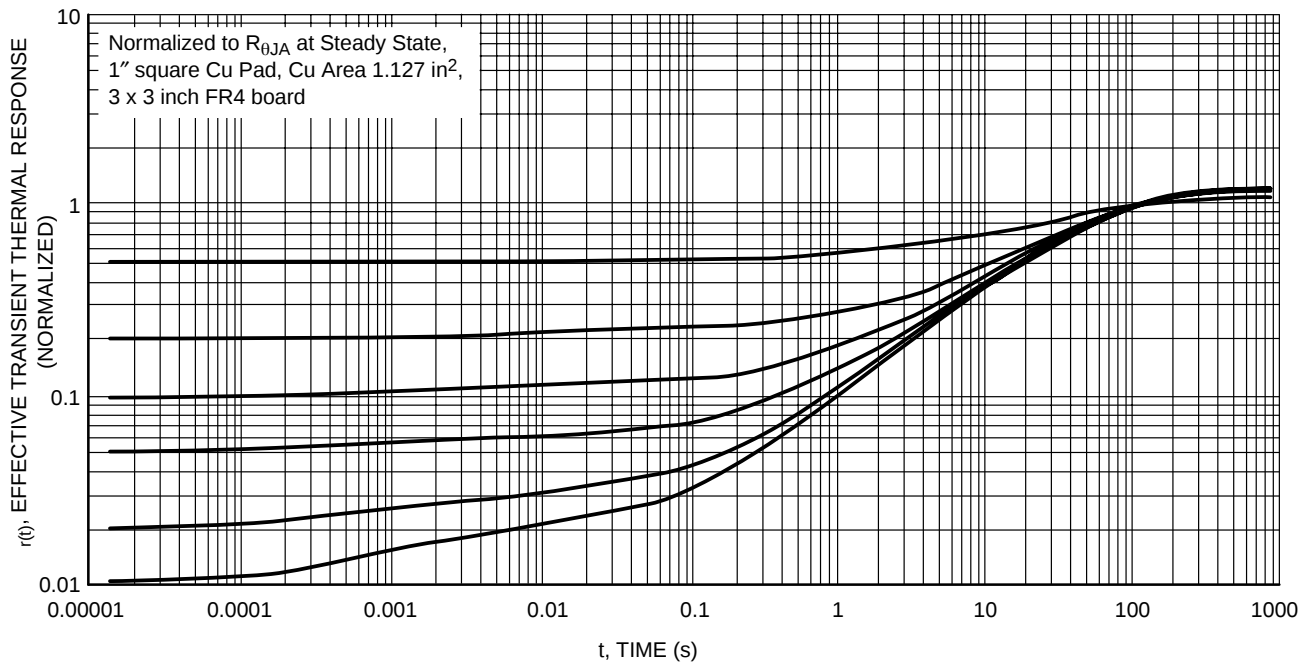


Figure 14. Thermal Response

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ORDERING INFORMATION

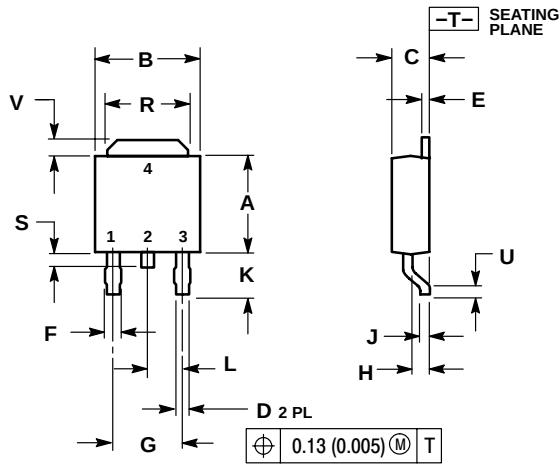
Device	Package	Shipping [†]
NTD32N06	DPAK	75 Units/Rail
NTD32N06G	DPAK (Pb-Free)	75 Units/Rail
NTD32N06-1	DPAK-3	75 Units/Rail
NTD32N06-1G	DPAK-3 (Pb-Free)	75 Units/Rail
NTD32N06T4	DPAK	2500 Tape & Reel
NTD32N06T4G	DPAK (Pb-Free)	2500 Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

NTD32N06

PACKAGE DIMENSIONS

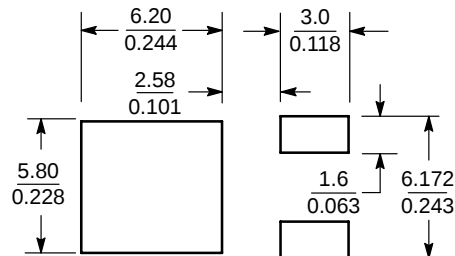
DPAK
CASE 369C-01
ISSUE O



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.235	0.245	5.97	6.22
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020	---	0.51	---
V	0.035	0.050	0.89	1.27
Z	0.155	---	3.93	---

STYLE 2:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

SOLDERING FOOTPRINT*



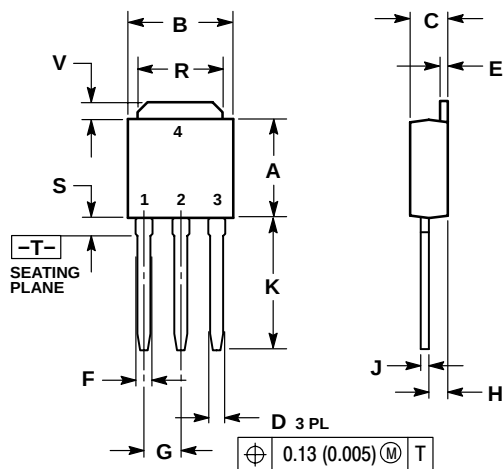
SCALE 3:1 (mm inches)

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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PACKAGE DIMENSIONS

DPAK-3 CASE 369D-01 ISSUE B



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.235	0.245	5.97	6.35
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Z	0.155	---	3.93	---

STYLE 2:

- PIN 1. GATE
- DRAIN
- SOURCE
- DRAIN

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